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# Automatic Intrinsic Calibration of Double-Sided Silicon Strip Detectors

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## Abstract

A reliable and simple-to-use algorithm was developed for the energy-calibration of double-sided silicon strip detectors (DSSSD). It works by enforcing mutual consistency of p-side and n-side information for every detected event. The procedure does not rely on a dedicated data set for calibration and is robust enough to work fully automated without human supervision. The method was developed and applied to data from a DSSSD of the Lund-York-Cologne Calorimeter (LYCCA) for the HISPEC experiment at FAIR. It has been tested on ions in the  $A \approx 90$  mass range at energies of  $E_{\text{kin}} \approx 300$  MeV/u.

*Keywords:* calibration procedure, silicon strip detector, energy loss measurement

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## 1. Introduction

Double-sided silicon strip detectors (DSSSD) are widely used for charged particle detection in nuclear and particle physics experiments to obtain position, energy or energy-loss information and particle identification [1]. They are  
5 constructed as large area silicon detectors with segmented p-side and n-side contacts. The intersecting areas of both side's segments form pixels. All signals on both sides are read out through individual channels. For each event, the channel numbers on both sides indicate the pixel that was hit by the charged particle.

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Typical applications for DSSSDs make use of square [1] or circular shapes [2] (see Fig. 1). In applications where energy information is required, it is essen-

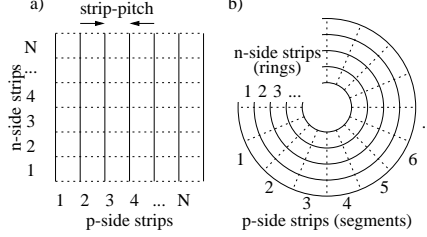


Figure 1: Schematic view of two common configurations for DSSSDs: a) shows a rectangular shaped, b) a circular shaped segmentation layout. Solid and dashed lines indicate the borders of front-side and back-side segments, respectively.

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tial to calibrate the individual segments of the DSSSD. We distinguish between “absolute” and “intrinsic” calibration of such detectors in the following way: By “absolute energy calibration”, we refer to a set of calibration coefficients that map measured amplitudes to units of energy. A set of coefficients can be  
 15 obtained by recording spectra for all segments using particle sources of known energy, such as  $\alpha$ -sources, or a particle beam from an accelerator. By analyzing these spectra, single segment gains can be obtained in units of energy per ADC-channel. In addition, pulsed sources can be used to inject charge with calibrated value into the front end electronics (FEE)<sup>1</sup> of all strips [2], to correct for non-  
 20 linearities in the FEE. For highly segmented DSSSDs, this procedure is difficult for two reasons: First, the analysis has to be performed for each channel, i.e. the effort increases with the number of channels. Second, and more important, the active area per segment decreases with higher segmentation. Consequently, a long measurement time for calibration is required to accumulate a sufficient  
 25 number of events in the calibration spectra. This can be exceedingly expensive if an accelerator is used as a calibration source.

An absolute calibration implies that all segments deliver comparable infor-

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<sup>1</sup>only the FEE, not the detector itself is calibrated by this method

mation about the energy-loss of a particle, i.e. the information doesn't depend on which strip was hit. If this is the case, but the absolute energy scale is not  
 30 determined, we call this “intrinsic calibration”. Intrinsic calibration of the individual strips of the detector is sufficient, for example in particle tracking and identification applications [1, 3].

A detector with pre-existing intrinsic calibration of the individual strips is easier to calibrate absolutely with known sources. The problem of increasing  
 35 measurement time for highly segmented detectors does not occur, because the segmentation does not matter anymore, as far as the calibration spectrum is concerned.

In this work we will show that it is possible to obtain an intrinsic calibration for DSSSDs by using the correlations of p-side and n-side data. We demon-  
 40 strate this by presenting one possible algorithm that exploits these correlations to obtain a set of intrinsic calibration coefficients from any data set from the detector. Further, we show results of its application to data from a DSSSD, that was used as part of the Lund-York-Cologne-Calorimeter (LYCCA), a detector system for relativistic heavy-ion identification and tracking. Finally, limitations  
 45 and possible improvements of the method will be discussed.

## 2. Method

For a single event of energy deposition inside a DSSSD, the created charge carriers induce signals in all electrical segments as they move within the detector volume. The measured signal amplitudes depend on the geometry of the de-  
 50 tector and its segmentation, in particular, of the distance between the segment and the location of charge carriers. Cross-talk between different channels in the FEE can modify the signal amplitudes of all channels. The presented algorithm neglects cross-talk in the FEE and assumes that there is at least a fraction of events, where the deposited energy

$$E = s_i A_i, \tag{1}$$

55 in the detector is proportional to a signal in channel  $i$  of amplitude  $A_i$ , and that all other channel amplitudes are negligible:

$$A_i \gg A_j \quad \text{for } i \neq j. \quad (2)$$

The slope factor  $s_i$  is the only calibration coefficient for a given channel  $i$ . In section 4 we will generalize (1), allowing for an additional offset in the energy dependence. Note, that the principle of correlating p-side and n-side information  
60 does not demand the exclusion of cross-talk and multi-segment hits. However, this simplified treatment turned out to be sufficient for achieving good results as will be shown in Section 5.

The basic idea of the procedure is the following: Given a DSSSD with  $N_p$  and  $N_n$  strips on the p-side and n-side, respectively, each event that is registered  
65 in a given pixel will create a signal with amplitude  $A_p$  in the strip number  $p$  on the p-side and a signal with amplitude  $A_n$  in strip number  $n$  on the n-side ( $n, p = 1 \dots N_{n,p}$ ). Assuming that both strips measure the same deposited energy  $E$  in the active area of the detector, one can write

$$E_p = s_p A_p, \quad E_n = s_n A_n \quad \text{and} \quad E_p = E_n = E, \quad (3)$$

with  $s_p$  and  $s_n$  being the calibration coefficients (slopes) for the  $p$ -th p-side  
70 strip and the  $n$ -th n-side strip, respectively. For each pixel that was hit, the corresponding segments on both sides will deliver signal amplitudes,  $A_p$  and  $A_n$ , that are unambiguously related. Since we assume in this section that Eq. (1) is valid, this relation between the two measured amplitudes is also linear without offset

$$A_p = S_{pn} A_n. \quad (4)$$

75 The slope  $S_{pn} = A_p/A_n$  of this line can be experimentally determined for each pixel, based on a given set of measured events. A schematic representation of the relations can be seen in Fig. 2. For each pixel, this slope can be visualized by plotting for each event the amplitudes ( $A_p$  and  $A_n$ ). Fig. 3 shows such a plot for measured data of a single DSSSD pixel, which allows to determine  $S_{pn}$   
80 and it's uncertainty  $\Delta S_{pn}$  for this pixel. The set of  $N_p N_n$  measured  $S_{pn}$ -values

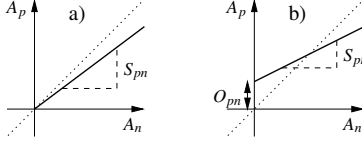


Figure 2: The relation between  $A_p$  and  $A_n$  for one single pixel of the detector (thick, solid line) with slope  $S_{pn}$ . In general, this line does not coincide with the diagonal (dotted line). In a) no offset is present, while in b) an offset  $O_{pn}$  is allowed (see section 4).

can be used to get a set of  $N_p + N_n$  calibration coefficients  $\{s_p, s_n\}$  that best reproduces the set of measured  $\{S_{pn}\}$ . Both sets are related by

$$S_{pn} = \frac{s_n}{s_p}, \quad (5)$$

which follows from Eqs. (3,4). One way of finding a set of  $2N$  calibration parameters  $\{s_p, s_n\}$  is to minimize the following expression

$$\chi^2 = \sum_{p,n} \left( \frac{S_{pn} - \frac{s_n}{s_p}}{\Delta S_{pn}} \right)^2, \quad (6)$$

85 where  $\Delta S_{pn}$  is the experimental uncertainty for the pixel slopes  $S_{pn}$ . The calibration parameters that minimize (6), also fulfill the condition (3) and therefore represent the best set of calibration coefficients for a given input data set on an arbitrary scale, if the simplifying assumptions are valid.

The proposed method, as described above, requires the following conditions  
90 to be fulfilled: It is essential, that p-side and n-side strips have intersection points and that both side's strips are read-out. In addition, a sufficient amount of single-strip events has to be present, i.e. events where (2) is valid. Events with inter-strip hits on one or both sides will contribute to the background and should be excluded from the calibration procedure. Note, that this procedure  
95 could also be applied to detectors with segmentation on one side only, as long as signals from all segments and the un-segmented side are recorded.

### 3. Implementation

The presented implementation uses two essentially independent steps: First, the determination of  $S_{pn}$  and the uncertainty  $\Delta S_{pn}$  for each pixel from measured

100 data. Second, the calculation of a set of calibration coefficients  $\{s_p, s_n\}$  based  
 on the set of  $\{S_{pn}, \Delta S_{pn}\}$  from the first step. The former is done using a  
 Bayesian [4] approach, and the latter is done by using a nonlinear least squares  
 fit algorithm. Both steps are described in the following two subsections.

### 3.1. Determination of $S_{pn}$

105 For all pixels, the slope coefficient  $S_{pn} = A_p/A_n$  is computed from the data  
 obtained from  $M$  selected events in the detector, each event consisting of two  
 amplitude measurements  $A_{p,i}, A_{n,i}$  that obey (2). An obvious way to determine  
 $S_{pn}$ , would be a straight line fit to the 2d-distribution of all amplitude pairs  
 using a  $\chi^2$  minimization procedure, as illustrated in Fig. 3. The slope of that  
 line would correspond to  $S_{pn}$ . Doing so, the resulting  $S_{pn}$  has a systematic

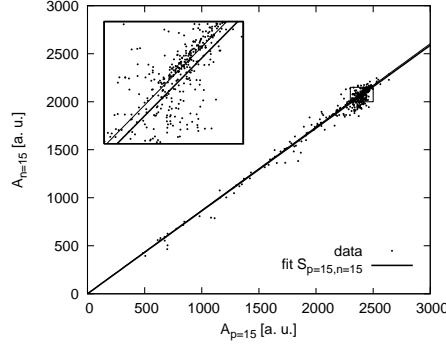


Figure 3: This plot shows a typical distribution p/n-side amplitude pairs (dots) for a single pixel ( $p=15, n=15$ ), after selecting single-strip events on both sides as described in section 2. Even though there is not much background, a simple  $\chi^2$ -fit (thick, solid line) of the slope  $S_{pn}$  misses the correct value. The inset shows a zoom-in to the most densely populated part of the graph where the mismatch of data and  $\chi^2$ -fit is obvious to the human eye. For comparison, the thin solid line shows the result determined by our algorithm.

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error, as can be seen in the inset of Fig. 3. This is because the  $\chi^2$  minimization procedure assumes a Gaussian distribution of the individual points around the fitted function, and the result can be significantly changed if some points violate this assumption. There are several suggestions in [4] to overcome this problem.

115 One approach is to assume distributions with outreaching tails for data points



around the fitted function, such as the Cauchy-Lorentz distribution. This weakens the impact of few outliers in the data. Instead of implementing such a fitting routine and apply it to the input data, it is possible to compute a probability distribution for the quantity of interest directly, by repeated usage of Bayes' theorem (7). This is simple to implement because it requires for each event, a point-by-point multiplication of two functions, namely the distribution based on all previous events and the likelihood function of the current event. After multiplication, a normalization step follows to qualify the result as probability distribution. The details are described in the following:

Our goal is the computation of the posterior probability distribution  $p(S_{pn} | \{A_p, A_n\}_M)$  of the quantity of interest  $S_{pn}$  for all pixels of the detector. The notation was adopted from [4], where  $p(x|y) dx$  is a function of the variable  $x$  that gives the probability of having  $x$  in the interval  $[x, x + dx]$  if some condition (or information)  $y$  is given. We define the subset  $\{A_p, A_n\}_i := \{A_{p,1}, A_{n,1}, A_{p,2}, A_{n,2}, \dots, A_{p,i}, A_{n,i}\}$  as the data obtained from the first  $i$  measured events. Obviously,  $\{A_p, A_n\}_M$  is the set of all measured events. The most likely value for the slope parameter  $S_{pn}$  and its error  $\Delta S_{pn}$  for each  $p$  and  $n$  can be obtained from the mean and variance of the final posterior distribution. Calculating  $p(S_{pn} | \{A_p, A_n\}_M)$  is done iteratively, treating one event after the other, while the width of the distribution becomes narrower with each step. The iteration starts with an initial guess for the  $p_0(S_{pn})$  distribution, in this case uniform within reasonable limits  $S_{\min}$  and  $S_{\max}$ . These limits should cover all occurring values of  $S_{pn}$ , which can be estimated by the maximum expected ratio of gains in all channels:  $S_{\min} < \min(s_n/s_p)$  and  $S_{\max} > \max(s_n/s_p)$ . For example, if the smallest gain is expected to be no less than 10 times the largest gain,  $S_{pn}$  can be inside the interval  $[0.1, 10]$ . For each event,  $p_0(S_{pn})$  is refined by applying Bayes' theorem [4, 5, 6]

$$p_i(S_{pn} | \{A_p, A_n\}_i) = \frac{p_i(S_{pn}) L(A_{p,i}, A_{n,i} | S_{pn})}{p(A_{p,i}, A_{n,i})}, \quad (7)$$

with the commonly used terminology [4]:  $p_i(S_{pn} | \{A_p, A_n\}_i)$  is called *posterior* distribution,  $p_i(S_{pn})$  is the *prior* distribution,  $L(A_{p,i}, A_{n,i} | S_{pn})$  the *likelihood*

145 function and  $p(A_{p,i}, A_{n,i})$  is a normalization factor that is also called *evidence* of the measured data. Index  $i$  indicates the iteration step. After each event, the normalized posterior distribution becomes the prior for the next data point

$$p_{i+1}(S_{pn}) = p_i(S_{pn} | \{A_p, A_n\}_i), \quad (8)$$

and the final distribution is obtained at the last iteration. The likelihood function is chosen to be a Cauchy-Lorentz distribution with width  $w$

$$L(A_{p,i}, A_{n,i} | S_{pn}) \propto \frac{1}{w^2 + \left(\log \frac{A_{p,i}}{A_{n,i}} - \log S_{pn}\right)^2}. \quad (9)$$

150 This particular choice for the likelihood function was inspired by the aforementioned treatment of fitting data with outliers in [4]. Other distributions were not tested, because satisfactory results were obtained.

According to the central limit theorem, the posterior distribution approaches a Gaussian shape. However, no analytic expression for the distribution at intermediate steps of the calculation is known. Thus, the posterior distribution has 155 to be approximated by a discrete number  $K$  of points between  $S_{\min}$  and  $S_{\max}$ . The value of  $K$  depends on the chosen limits  $S_{\min, \max}$  and the desired accuracy of the final result. Typical values are in the order of a few thousand.

### 3.2. Computing a set of calibration coefficients

160 Minimization of (6) is done using the implementation of a standard non-linear least squares fit provided by the GNU Scientific Library [7]. The set of fit parameters is  $\{s_p, s_n\}$ , and the input data is the complete set of measured parameters  $\{S_{pn}\}$ . To allow for a unique solution, one out of the  $N_p + N_n$  parameters has to be fixed, for example by setting one of the p-side slopes to 1. The algorithm attempts to minimize Eq. (6) with respect to the remaining 165  $N_p + N_n - 1$  parameters. After convergence is reached, the resulting parameter set describes the best intrinsic calibration coefficients for the individual strips relative to each other on a common arbitrary scale. The algorithm works automatically in the following sense: Once a good parameter set  $(K, S_{\min}, S_{\max}, w)$

170 is found for a detector, intrinsic calibration coefficients can be found for it by  
analyzing any measured data set.

#### 4. Offset determination

For cases in which the offsets are not negligible, the method can be extended  
to take them into account. This was done in the following way: An offset  $o$  is  
175 added to Eq. (1)

$$E = o + s A. \quad (10)$$

If offsets are allowed, the linear dependence between  $A_p$  and  $A_n$  is also allowed  
to have an offset  $O_{pn}$ . This changes Eq. (4) into (see Fig.2 b)

$$A_p = O_{pn} + S_{pn} A_n. \quad (11)$$

The first step, determination of  $O_{pn}$  and  $S_{pn}$ , can be achieved with two-dimensional  
probability density functions  $p(S_{pn}, O_{pn} | \{A_p, A_n\})$ . The basic procedure is the  
180 same as described in 3.1. Only the likelihood function has to be extended from  
(9) to be two-dimensional, taking into account the correlation between offset  
and slope:

$$L(A_{p,i}, A_{n,i} | S_{pn}, O_{pn}) \propto \frac{1}{w^2 + \left( \log \frac{A_{p,i} - O_{pn}}{A_{n,i}} - \log S_{pn} \right)^2}. \quad (12)$$

For the numerical approximation, a range of possible offset parameters  $O_{pn}$  has  
to be specified by two additional parameters,  $O_{\min}$  and  $O_{\max}$ . These limits  
185 have to be chosen such, that they include all occurring  $O_{pn}$  as defined in (13).  
The numerical approximation of the two-dimensional posterior distribution in  
a computer requires significantly more memory and computation time than in  
the one-dimensional case, but it is possible on nowadays desktop computers.

The second step, calculation of the coefficients for each strip, has to be  
190 modified as well. All relevant quantities are related as in Eq. (5), but with an  
additional equation for the offset:

$$S_{pn} = \frac{s_n}{s_p} \quad \text{and} \quad O_{pn} = \frac{o_n - o_p}{s_p}. \quad (13)$$

With the modified relations of Eq. (13), the set of  $2N_p + 2N_n - 2$  calibration parameters  $\{o_p, s_p, o_n, s_n\}$  can be found by minimizing Eq. (14), which is an extended form of Eq. (6):

$$\chi^2 = \sum_{p,n} \left( \frac{S_{pn} - \frac{s_n}{s_p}}{\Delta S_{pn}} \right)^2 + \left( \frac{O_{pn} - \frac{o_n - o_p}{s_p}}{\Delta O_{pn}} \right)^2. \quad (14)$$

where  $S_{pn}$ ,  $O_{pn}$  and  $\Delta S_{pn}$ ,  $\Delta O_{pn}$  are mean and variance of the final distribution  $p(S_{pn}, O_{pn} | \{A_p, A_n\})$ . Again, two parameters have to be fixed to find a unique solution, for example  $o_N = 0$  and  $s_N = 1$ .

## 5. Experimental Data

The method was developed and tested, using data from one of the DSSSDs of LYCCA [1], which is part of the PreSPEC-AGATA setup [8] at the GSI Helmholtzzentrum for Heavy Ion Research. Results shown here are based on data from the PreSPEC-AGATA campaign in 2012. During that campaign, LYCCA contained 17 DSSSD modules, each being 300  $\mu\text{m}$  thick. We present data for the DSSSD close to the position of the secondary target with 32 strips on both sides. The strip pitch is 1.8 mm, with an inter-strip isolation of 30  $\mu\text{m}$ . A schematic block diagram of the read-out chain is shown in Fig. 4. More details about the FEE are described in [1]. A primary beam of  $^{86}\text{Kr}$

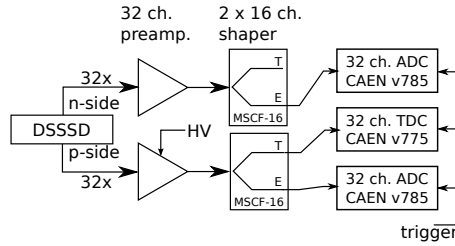


Figure 4: Custom made preamplifiers [1] are used to provide differential input signal for the commercially available MSCF-16. These modules contain sixteen channel shaping amplifiers and timing filter amplifiers with leading edge discriminators. The MSCF-16 output is recorded by two CAENv758 ADC and a CAENv757 TDC inside a VME crate that is part of the PreSPEC MBS data-acquisition system.

was accelerated with the GSI Universal Linear Accelerator (UNILAC) and the SchwerIonen Synchrotron (SIS18). A mixture of different nuclear species was  
 210 created by the collision of the primary beam with a thick beryllium target. The GSI Fragment Separator (FRS) [9] was tuned to select an almost pure beam of  $^{85}\text{Br}$  ions with kinetic energies of about 306 MeV/u when entering the DSSSD. Under these conditions about 255 MeV are deposited inside the DSSSD, according to a calculation with the computer program LISE++ [10].

## 215 6. Results

In the following all, presented data is after selecting single strip events according to (2). Fig. 5 shows the amplitude of the n-side plotted versus the

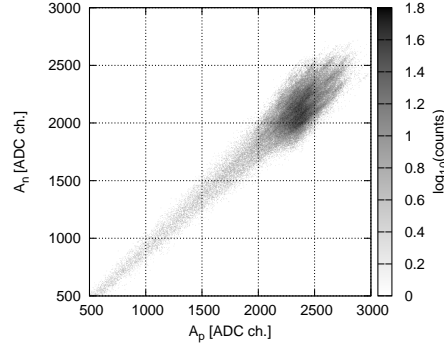


Figure 5: Shown is an overlay histogram of n-side amplitude  $A_n$  vs p-side amplitude  $A_p$  for all possible pairings of n and p. The broad structure can be interpreted as an overlay of all lines with slopes  $S_{pn}$ . After applying the calibration procedure, the picture changes to Fig. 6.

amplitude of the p-side, for events with strip multiplicity one on both sides. The histogram is the sum of all pixels of the detector. Without calibration,  
 220 the p-side and n-side amplitudes are in general different from each other, resulting in a broad structure around the  $A_n = A_p$  diagonal. After applying the calibration procedure described in this work, the outputs of all pixels are aligned. This is verified by Fig. 6, where the amplitudes were multiplied with their respective gain-match factors  $s_p$  and  $s_n$ . The parameters for the algo-

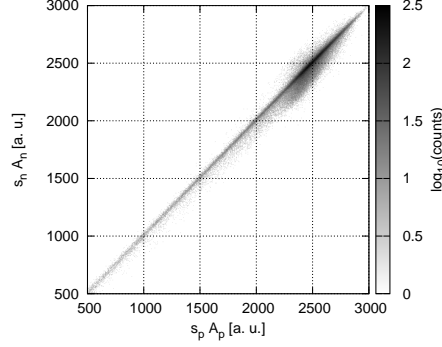


Figure 6: Overlay histogram of calibrated n-side amplitude  $s_n A_n$  vs calibrated p-side Amplitude  $s_p A_p$  for all possible pairings of n and p. Calibration factors  $s_n$  and  $s_p$  were determined using the method described in this work. Obviously, p- and n-side energy measurements are in agreement, regardless of which pair of strips is hit.

225 rithm were for the no-offset version 5000, 0.6, 1.4, 0.01 for  $K, S_{\min}, S_{\max}$  and  $w$ , respectively. For the algorithm with offset determination, the parameter set was 800, 0.6, 1.4, 0.01, 200, -200, 200 for  $K_s, S_{\min}, S_{\max}, w, K_o, O_{\min}$  and  $O_{\max}$ , respectively.

In order to quantify the relative resolution of the detector at different amplitudes, the disagreement between calibrated p-side and n-side amplitudes  
230  $s_p A_p - s_n A_n$  is plotted over the calibrated p-side amplitude  $s_p A_p$  in Fig. 7. This plot contains essentially the same information as 6, but the diagonal is transformed onto the  $s_p A_p$ -axis, and allows for determination of the width of the distribution by projecting to the other axis. If no offsets are determined,  
235 the resulting calibration will have the best resolution at the most intense part of the energy spectrum, where most of the recorded events are situated. The resolution gets worse for events where the amplitude differs significantly from the peak in the spectrum. This effect is highlighted in Fig. 8, where the achieved resolution for different regions of the amplitude spectrum is shown. If the full  
240 range of the spectrum is of relevance, offsets shouldn't be neglected. In the lower parts of the spectrum with less intensity, the resolution of the slope-only calibration is significantly worse than the one including offsets.

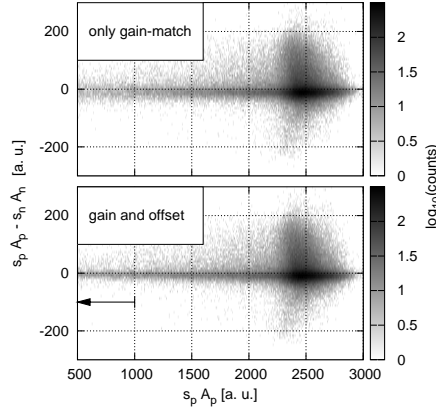


Figure 7: Both histograms show the difference of the calibrated amplitude of p-side and n-side, plotted over the calibrated p-side amplitude (similar information as Fig. 6). In the upper picture, the calibration procedure was applied without determining offsets. The lower picture shows the improvement after the calibration of both, offsets and gains. Differences are predominantly apparent for events with lower amplitudes (indicated by the arrow), where the missing offsets have a significant impact. This can be seen even better in Fig. 8.

The peaks in Fig. 8 can be used to estimate the relative resolution of the detector. The width (FWHM) of that peak amounts to  $\Delta = 27.4$  a.u.. Assuming  
 245 that both sides measure the same energy independently with approximately the same accuracy, i.e.  $\sigma_p \approx \sigma_n \approx \sigma$ , the difference of the measurements of both sides will have a width of  $\Delta = \sqrt{\sigma_p^2 + \sigma_n^2} \approx \sqrt{2} \sigma$ . If both, p and n-side measurement are combined to form an average, the uncertainty of the measured energy deposition can be approximated with  $\sigma/\sqrt{2} = \Delta/2$ . The peak width  $\Delta$   
 250 is dominated by events with an amplitude of around 2400 a.u. (see Fig. 6), which corresponds to the energy loss of the  $^{85}\text{Br}$  particles. Thus, the relative resolution in the most relevant region of the spectrum corresponds to 0.57 % at 255 MeV, which is well within the expected range between 0.5 % and 1 %, as stated in [1]. This indicates, that the calibration method works correctly. Note,  
 255 that the method was tested for fast particles, where none of them is stopped inside the detector material. Since the only assumption is the agreement of n-side and p-side charge collection, it should work as well for lower energies when particles are implanted.

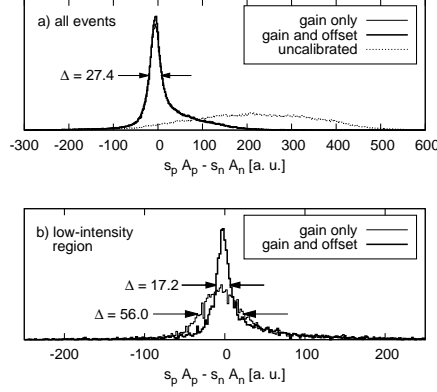


Figure 8: a) The difference of calibrated p-side and n-side amplitude for all amplitudes. b) The same quantity for amplitudes below a value of 1000 as indicated by the arrow in Fig 7.  $\Delta$  indicates the full width at half maximum of the peaks.

## 7. Possible Improvements

260 In the procedure described here, the user has to fix the parameters for the range of the probability distributions and their density of points. If the range is not known, the user has to choose a wide and fine enough grid for the representation of the distribution and pays with longer computation time and more memory consumption. Especially in the case of two-dimensional distributions  
 265 for gain and offset determination, this can reach the limits of the available hardware in a common desktop computer. Therefore, it would be a significant improvement in performance and usability, if the probability distributions would be adaptive in range and density of points. If such an improvement would be implemented, the only remaining parameter would be the width  $w$  of the likelihood  
 270 function in Eqs. (9,12).

For the calibration with offsets, there is a strong negative correlation between the measured quantities  $S_{pn}$  and  $O_{pn}$ . This could be taken into account by minimizing, instead of Eq. (14), the expression

$$\chi_{\text{cor}}^2 = \sum_{p,n} \left( S_{pn} - \frac{s_n}{s_p}, O_{pn} - \frac{o_n - o_p}{s_p} \right) \text{Cov}_{pn}^{-1} \left( S_{pn} - \frac{s_n}{s_p}, O_{pn} - \frac{o_n - o_p}{s_p} \right). \quad (15)$$



with  $\text{Cov}_{pn}^{-1}$  the inverse of the covariance matrix of the posterior probability  
 275 distribution  $p(S_{pn} | \{A_p, A_n\}_M)$ . This should improve the precision of the cali-  
 bration coefficients for the same amount of data.

## 8. Summary

A reliable method for the intrinsic calibration of DSSSD strips among each  
 other was developed, implemented and tested with in-beam production data.  
 280 The main advantage over conventional calibration procedures is the ability to  
 work with any data set with any kind of energy distribution. If an absolute en-  
 ergy calibration of the detector is needed, the method can still be of considerable  
 use if it is applied before the absolute calibration, in which case the detector can  
 be treated as one device instead of a collection of independent strips. Possible  
 285 future improvements of the implementation have been suggested.

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